

August 1999 Revised October 1999

74ACT16646

16-Bit Transceiver/Register with 3-STATE Outputs

General Description

The ACT16646 contains sixteen non-inverting bidirectional registered bus transceivers providing multiplexed transmission of data directly from the input bus or from the internal storage registers. Each byte has separate control inputs which can be shorted together for full 16-bit operation. The DIR inputs determine the direction of data flow through the device. The CPAB and CPBA inputs load data into the registers on the LOW-to-HIGH transition.

Features

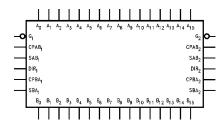
- Independent registers for A and B buses
- Multiplexed real-time and stored data transfers
- Separate control logic for each byte
- 16-bit version of the ACT646
- Outputs source/sink 24 mA
- TTL-compatible inputs

Ordering Code:

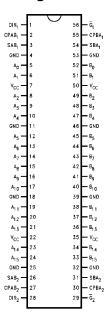
Order Number	Package Number	Package Description
74ACT16646SSC	MS56A	56-Lead Shrink Small Outline Package (SSOP), JEDEC MO-118, 0.300" Wide
74ACT16646MTD	MTD56	56-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 6.1mm Wide

Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code.

Logic Symbol



Connection Diagram



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DS500345

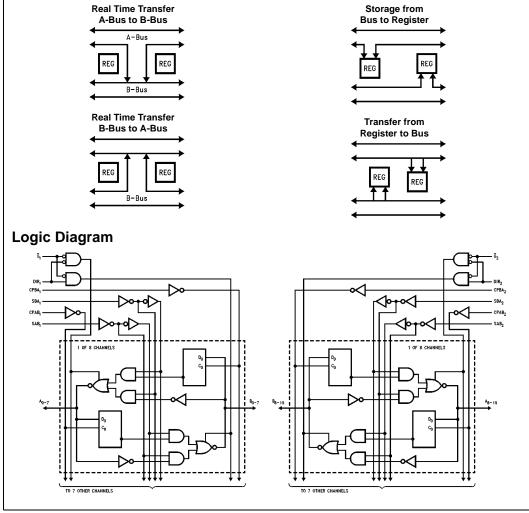
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Function Table

Inputs						Data I/O (Note 1)		Output Operation Mode		
G ₁	DIR ₁	CPAB ₁	CPBA ₁	SAB ₁	SBA ₁	A ₀₋₇ B ₀₋₇		Output Operation Mode		
Н	Х	H or L	H or L	Х	Х			Isolation		
Н	X	~	X	X	X	Input	Input	Clock A _n Data into A Register		
Н	X	X	~	Χ	X			Clock B _n Data Into B Register		
L	Н	Х	Х	L	Х			A _n to B _n —Real Time (Transparent Mode)		
L	Н	~	X	L	X	Input Output		Clock A _n Data to A Register		
L	Н	H or L	X	Н	X			A Register to B _n (Stored Mode)		
L	Н	~	X	Н	X			Clock A _n Data into A Register and Output to B _n		
L	L	Х	Х	Х	L			B _n to A _n —Real Time (Transparent Mode)		
L	L	X	~	X	L	Output	Input	Clock B _n Data into B Register		
L	L	X	H or L	X	Н			B Register to A _n (Stored Mode)		
L	L	Χ	~	Χ	Н			Clock B _n into B Register and Output to A _n		

 $\mbox{H = HIGH Voltage Level} \qquad \mbox{X = Immaterial} \qquad \mbox{L = LOW Voltage Level} \qquad \mbox{${\sim}$ = LOW-to-HIGH Transition}.$

Note 1: The data output functions may be enabled or disabled by various signals at the G and DIR inputs. Data input functions are always enabled; i.e., data at the bus pins will be stored on every LOW-to-HIGH transition of the appropriate clock inputs. Also applies to data I/O (A and B: 8-15) and #2 control pins.



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Absolute Maximum Ratings(Note 2)

Supply Voltage (V_{CC}) -0.5V to +7.0V

DC Input Diode Current (I_{IK})

 $\begin{array}{ll} V_{I} = -0.5 V & -20 \text{ mA} \\ V_{I} = V_{CC} + 0.5 V & +20 \text{ mA} \end{array} \label{eq:vi}$

DC Output Diode Current (I_{OK})

 $V_{O} = -0.5V$ -20 mA $V_{O} = V_{CC} + 0.5V$ +20 mA

DC Output Voltage (V_O) -0.5V to V_{CC} + 0.5V DC Output Source/Sink Current (I_O) ± 50 mA

DC V_{CC} or Ground Current

per Output Pin $\pm 50 \text{ mA}$ Storage Temperature -65°C to $+150^{\circ}\text{C}$

Recommended Operating Conditions

 $\begin{array}{lll} \mbox{Supply Voltage (V_{CC})} & 4.5\mbox{V to } 5.5\mbox{V} \\ \mbox{Input Voltage (V_{O})} & 0\mbox{V to V_{CC}} \\ \mbox{Output Voltage (V_{O})} & 0\mbox{V to V_{CC}} \\ \end{array}$

 $\begin{array}{lll} \text{Output Voltage (V_O)} & \text{OV to V}_{CC} \\ \text{Operating Temperature (T_A)} & -40^{\circ}\text{C to +85}^{\circ}\text{C} \\ \text{Minimum Input Edge Rate ($\Delta V/\Delta t$)} & 125 \text{ mV/ns} \\ \end{array}$

V_{IN} from 0.8V to 2.0V

V_{CC} @ 4.5V, 5.5V

Note 2: Absolute maximum ratings are those values beyond which damage to the device may occur. The databook specifications should be met, without exception to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. Fairchild does not recommend operation of FACTTM circuits outside databook specifications.

DC Electrical Characteristics

Symbol	Parameter	V _{CC}	V_{CC} $T_A = +25^{\circ}C$ $T_A = -40^{\circ}C$ to $+85^{\circ}C$ (V) Typ Guaranteed Limits		$+25^{\circ}$ C $T_{A} = -40^{\circ}$ C to $+85^{\circ}$ C		Conditions
Symbol	Falailletei	(V)			Units	Conditions	
V _{IH}	Minimum HIGH	4.5	1.5	2.0	2.0	V	$V_{OUT} = 0.1V$
	Input Voltage	5.5	1.5	2.0	2.0	v	or V _{CC} – 0.1V
V _{IL}	Maximum LOW	4.5	1.5	0.8	0.8	V	$V_{OUT} = 0.1V$
	Input Voltage	5.5	1.5	0.8	0.8	v	or V _{CC} – 0.1V
V _{OH}	Minimum HIGH	4.5	4.49	4.4	4.4	V	I _{OUT} = -50 μA
	Output Voltage	5.5	5.49	5.4	5.4	v	ι _{ΟυΤ} = -50 μΑ
							$V_{IN} = V_{IL} \text{ or } V_{IH}$
		4.5		3.86	3.76	V	$I_{OH} = -24 \text{ mA}$
		5.5		4.86	4.76		$I_{OH} = -24 \text{ mA (Note 3)}$
V _{OL}	Maximum LOW	4.5	0.001	0.1	0.1	V	I - FO A
	Output Voltage	5.5	0.001	0.1	0.1	v	I _{OUT} = 50 μA
							$V_{IN} = V_{IL}$ or V_{IH}
		4.5		0.36	0.44	V	I _{OL} = 24 mA
		5.5		0.36	0.44		I _{OL} = 24 mA (Note 3)
I _{OZT}	Maximum I/O	5.5		±0.5	±5.0	μА	$V_{IN} = V_{IL}, V_{IH}$
	Leakage Current	5.5		±0.5	±3.0	μΑ	$V_O = V_{CC}$, GND
I _{IN}	Maximum Input	5.5		±0.1	±1.0	μА	$V_1 = V_{CC}$, GND
	Leakage Current	0.0		20.1	11.0	μοι	VI = VCC, CIVE
I _{CCT}	Maximum I _{CC} /Input	5.5	0.6		1.5	mA	$V_I = V_{CC} - 2.1V$
Icc	Max Quiescent	5.5		8.0	80.0	μА	$V_{IN} = V_{CC}$ or GND
	Supply Current	5.5		0.0	00.0		AIN - ACC OL GIAD
I _{OLD}	Minimum Dynamic	5.5			75	mA	V _{OLD} = 1.65V Max
I _{OHD}	Output Current (Note 4)	5.5			-75	mA	V _{OHD} = 3.85V Min

Note 3: All outputs loaded; thresholds associated with output under test.

Note 4: Maximum test duration 2.0 ms; one output loaded at a time.

AC Electrical Characteristics

	Parameter	V _{CC}	$T_A = +25$ °C $C_L = 50 \text{ pF}$			$T_A = -40^{\circ}C$ to $+85^{\circ}C$ $C_L = 50 \text{ pF}$		Units
Symbol		(V)						
		(Note 5)	Min	Тур	Max	Min	Max	
t _{PHL}	Propagation Delay	5.0	4.6	6.9	9.4	3.6	10.1	ns
t _{PLH}	Clock to Bus	3.0	4.3	6.5	8.9	3.3	9.7	ns
t _{PHL}	Propagation Delay	5.0	4.0	6.2	8.5	2.9	9.2	ns
t _{PLH}	Bus to Bus	3.0	4.1	6.4	8.6	3.2	9.3	IIS
t _{PHL}	Propagation Delay	5.0	4.0	6.4	8.9	3.1	9.6	ns
t _{PLH}	Select to Bus	5.0	4.2	6.7	9.5	3.2	10.4	
	(w/An or Bn HIGH or LOW)							
t _{PZL}	Enable Time	5.0	5.3	7.8	10.5	3.8	11.4	ns
t _{PZH}	G to An/Bn	5.0	4.6	6.9	9.4	3.3	10.2	115
t _{PLZ}	Disable Time	5.0	3.0	5.5	8.1	2.3	8.6	ns
t _{PHZ}	G to An/Bn	5.0	3.4	5.7	8.3	2.6	8.6	115
t _{PZL}	Enable Time	5.0	5.1	8.2	11.8	4.3	12.7	ns
t _{PZH}	DIR to An/Bn	3.0	4.6	7.5	10.8	3.7	11.7	115
t _{PLZ}	Disable Time	5.0	2.9	5.8	9.2	2.0	9.8	20
t _{PHZ}	DIR to An/Bn	3.0	3.4	6.1	9.2	2.5	9.7	ns

Note 5: Voltage Range 5.0 is 5.0V ± 0.5V.

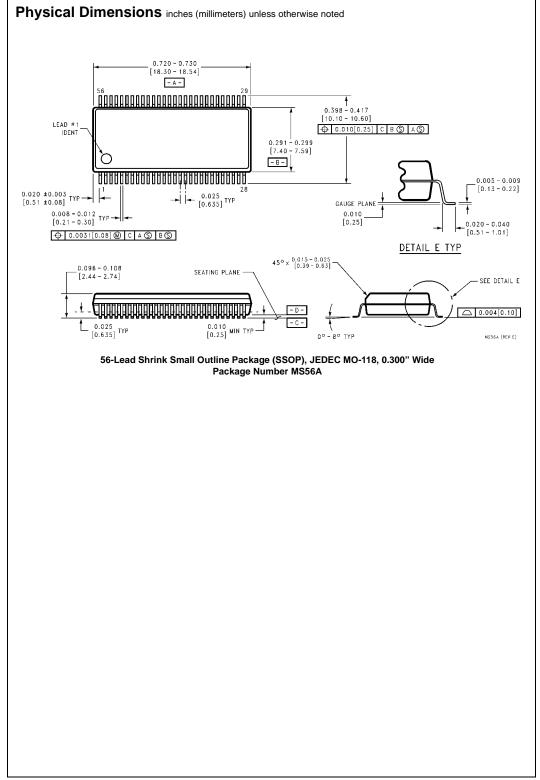
AC Operating Requirements

Symbol	Symbol Parameter		$T_A = +25^{\circ}C$ $C_L = 50 \text{ pF}$	$T_A = -40$ °C to +85°C $C_L = 50$ pF	Units	
		(Note 6)	Guarantee	d Minimum		
t _S	Setup Time, H or L Bus to Clock	5.0	3.0	3.0	ns	
t _H	Hold Time, H or L Bus to Clock	5.0	1.5	1.5	ns	
t _W	Clock Pulse Width H or L	5.0	4.0	4.0	ns	

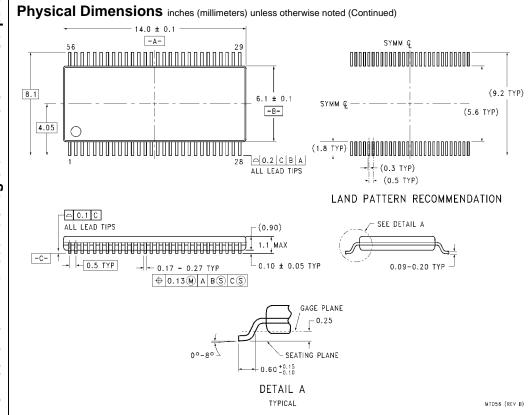
Note 6: Voltage Range 5.0 is 5.0V ± 0.5V.

Capacitance

Symbol	Symbol Parameter		Units	Conditions
C _{IN} Input Capacitance		4.5	pF	V _{CC} = 5.0V
C _{PD} Power Dissipation Capacitance		95	pF	V _{CC} = 5.0V



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56-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 6.1mm Wide Package Number MTD56

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